

3.3V Ringing SLIC Family for Voice Over Broadband (VOB)

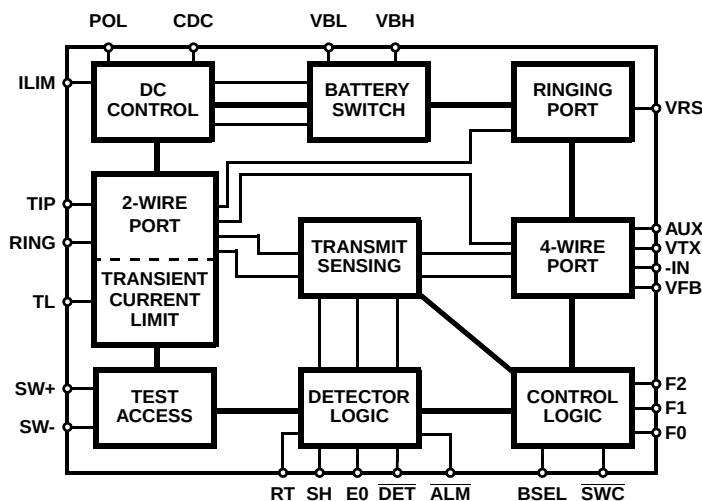
The 3.3V family of ringing subscriber line interface circuits (SLIC) supports analog Plain Old Telephone Service (POTS) in short and medium loop length, wireless and wireline voice over broadband applications. Ideally suited for customer premise equipment, this family of products offers flexibility to designers with high ringing voltage and low power consumption system requirements.

The ISL5585 family is capable of operating with 100V ringing battery supply, which translates directly to the amount of ringing voltage supplied to the subscriber. With the high operating voltage, subscriber loop lengths can be extended to 500Ω (i.e., 5,000 feet) and beyond, allowing this family to serve emerging Fiber In The Loop (FITL) markets.

Other key features across the product family include: 3.3V V_{CC} operation, low power consumption, ringing using sinusoidal or trapezoidal waveforms, robust auto-detection mechanisms for when subscribers go on or off hook, and minimal external discrete application components. Integrated test access features are also offered on selected products to support loopback testing as well as line measurement tests.

There are ten product offerings of the ISL5585 providing various grades of ringing battery voltage and longitudinal balance.

Block Diagram



Features

- 3.3V Operation
- Onboard Ringing Generation
- Low Standby Power Consumption (75V, 65mW)
- Programmable Transient Current Limit
- Improved Off Hook Software Interface
- Integrated MTU DC Characteristics
- Low External Component Count
- Silent Polarity Reversal
- Pulse Metering and On Hook Transmission
- Tip Open Ground Start Operation
- Balanced and Unbalanced Ringing
- Thermal Shutdown with Alarm Indicator
- 28 Lead Surface Mount Packaging
- QFN Package:
 - Compliant to JEDEC PUB95 MO-220 QFN - Quad Flat No Leads - Package Outline
 - Near Chip Scale Package footprint, which improves PCB efficiency and has a thinner profile
- Pb-Free Available (RoHS Compliant)

Applications

- Short Loop Access Platforms
- Voice Over Internet Protocol (VoIP)
- Voice Over Cable and DSL Modems
- Internet Protocol PBX
- FiberTo The Home (FTTH)
- Remote Subscriber Units
- Ethernet Terminal Adapters

Related Literature

- AN1038, User's Guide for Development Board
- AN9824, Modeling of the AC Loop
- TB379 Thermal Characterization of Packages for ICs
- AN9922, Thermal Characterization and Modeling of the RSLIC18 in the Micro Leadframe Package

Ordering Information

PART NUMBER	HIGH BATTERY (VBH)			LONGITUDINAL BALANCE		FULL TEST	TEMP. RANGE (°C)	PACKAGE	PKG. DWG. #
	100V	85V	75V	58dB	53dB				
ISL5585AIM	•			•		•	-40 to 85	28 Ld PLCC	N28.45
ISL5585AIMZ (See Note)	•			•		•	-40 to 85	28 Ld PLCC (Pb-free)	N28.45
ISL5585BIM		•		•		•	-40 to 85	28 Ld PLCC	N28.45
ISL5585BIMZ (See Note)		•		•		•	-40 to 85	28 Ld PLCC (Pb-free)	N28.45
ISL5585CIM	•				•	•	-40 to 85	28 Ld PLCC	N28.45
ISL5585CIMZ (See Note)	•				•	•	-40 to 85	28 Ld PLCC (Pb-free)	N28.45
ISL5585DIM		•			•	•	-40 to 85	28 Ld PLCC	N28.45
ISL5585DIMZ (See Note)		•			•	•	-40 to 85	28 Ld PLCC (Pb-free)	N28.45
ISL5585ECM			•		•		0 to 75	28 Ld PLCC	N28.45
ISL5585ECMZ (See Note)			•		•		0 to 75	28 Ld PLCC (Pb-free)	N28.45
ISL5585ECR			•		•		0 to 75	32 Pad QFN	L32.7x7*
ISL5585ECRZ (See Note)			•		•		0 to 75	32 Pad QFN (Pb-free)	L32.7x7*
ISL5585FCM			•		•	•	0 to 85	28 Ld PLCC	N28.45
ISL5585FCMZ (See Note)			•		•	•	0 to 85	28 Ld PLCC (Pb-free)	N28.45
ISL5585FCR			•		•	•	0 to 85	32 Pad QFN	L32.7x7*
ISL5585FCRZ (See Note)			•		•	•	0 to 85	32 Pad QFN (Pb-free)	L32.7x7*
ISL5585GCM	•				•	•	0 to 85	28 Ld PLCC	N28.45
ISL5585GCMZ (See Note)	•				•	•	0 to 85	28 Ld PLCC (Pb-free)	N28.45
ISL5585GCR	•				•	•	0 to 85	32 pad QFN	L32.7x7*
ISL5585GCRZ (See Note)	•				•	•	0 to 85	32 pad QFN (Pb-free)	L32.7x7*
ISL5585 XXX	Evaluation board platform, including CODEC.								

Also available in Tape and Reel

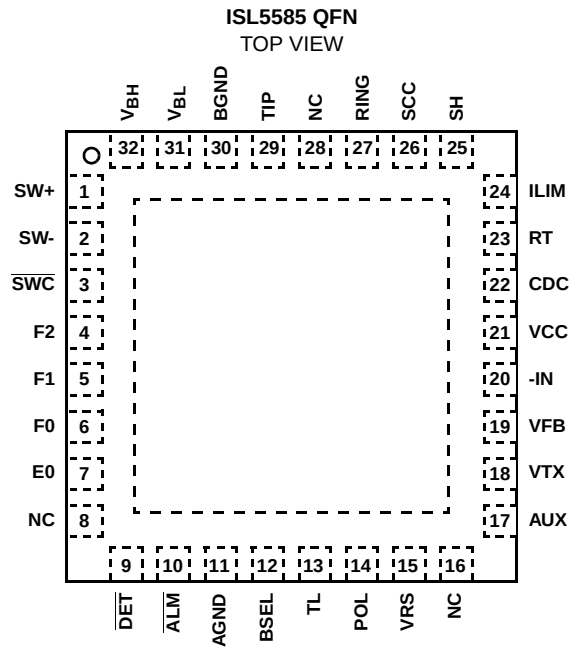
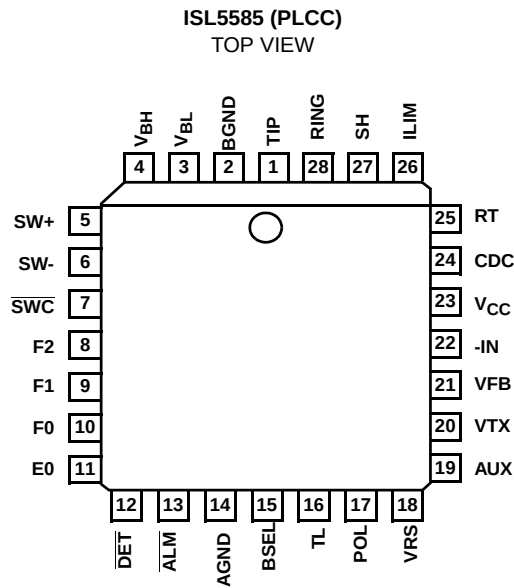
*Reference "Special Considerations for the QFN Package" text.

NOTE: Intersil Pb-free products employ special Pb-free material sets; molding compounds/die attach materials and 100% matte tin plate termination finish, which are RoHS compliant and compatible with both SnPb and Pb-free soldering operations. Intersil Pb-free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J STD-020C.

Device Operating Modes

MODE	F2	F1	F0	E0 = 1	E0 = 0	ISL5585A	ISL5585B	ISL5585C	ISL5585D	ISL5585E	ISL5585F	ISL5585G
Low Power Standby	0	0	0	SHD	GKD	•	•	•	•	•	•	•
Forward Active	0	0	1	SHD	GKD	•	•	•	•	•	•	•
Unbalanced Ringing	0	1	0	RTD	RTD							•
Reverse Active	0	1	1	SHD	GKD	•	•	•	•	•	•	•
Ringing	1	0	0	RTD	RTD	•	•	•	•	•	•	•
Forward Loop Back	1	0	1	SHD	GKD	•	•	•	•		•	•
Tip Open	1	1	0	SHD	GKD	•	•	•	•		•	•
Power Denial	1	1	1	n/a	n/a	•	•	•	•	•	•	•

Pinouts



Pin Description

PLCC	QFN	SYMBOL	DESCRIPTION
1	29	TIP	TIP power amplifier output.
2	30	BGND	Battery Ground - To be connected to zero potential. All loop current and longitudinal current flow from this ground. Internally separate from AGND. This ground must be connected to the same potential as AGND.
3	31	VBL	Low battery supply connection.
4	32	VBH	High battery supply connection for the most negative battery.
5	1	SW+	Uncommitted switch positive terminal.
6	2	SW-	Uncommitted switch negative terminal.
7	3	SWC	Switch control input. This TTL compatible input controls the uncommitted switch, with a logic "0" enabling the switch and logic "1" disabling the switch.
8	4	F2	Mode Control Input - MSB. F2-F0 for the TTL compatible parallel control interface for controlling the various modes of operation of the device.
9	5	F1	Mode control input.

Pin Description (Continued)

PLCC	QFN	SYMBOL	DESCRIPTION
10	6	F0	Mode control input.
11	7	E0	Detector Output Selection Input. This TTL input controls the multiplexing of the SHD (E0 = 1) and GKD (E0 = 0) comparator outputs to the DET output based upon the state at the F2-F0 pins (see the Device Operating Modes table shown on page 2).
12	9	DET	Detector Output - This TTL output provides on-hook/off-hook status of the loop based upon the selected operating mode. The detected output will either be switch hook, ground key or ring trip (see the Device Operating Modes table shown on page 2). $\overline{\text{DET}}$ will be latched low following a ring trip. Unlatching the $\overline{\text{DET}}$ pin is accomplished by changing logic state.
13	10	ALM	Thermal Shutdown Alarm. This pin signals the internal die temperature has exceeded safe operating temperature (approximately 175°C) and the device has been powered down automatically.
14	11	AGND	Analog ground reference. This pin should be externally connected to BGND.
15	12	BSEL	Selects between high and low battery, with a logic "1" selecting the high battery and logic "0" the low battery.
16	13	TL	Programming pin for the transient current limit feature, set by an external resistor to ground.
17	14	POL	External capacitor on this pin sets the polarity reversal time.
18	15	VRS	Ringing Signal Input - Analog input for driving 2-wire interface while in Ring Mode.
19	17	AUX	Auxiliary input - Float if not used.
20	18	VTX	Transmit Output Voltage - Output of impedance matching amplifier, AC couples through a resistor to CODEC.
21	19	VFB	Feedback voltage for impedance matching. This voltage is scaled to accomplish impedance matching. The CFB capacitor connects between this pin and the -IN pin. The CFB cap needs to be non-polarized for proper device operation in the Reverse Active mode. Ceramic surface mount capacitors (1206 body style) are available from Panasonic with a 6.3V voltage rating. These can be used for CFB since it is internally limited to approximately $\pm 3V$.
22	20	-IN	Analog Receive Voltage - 4-wire analog audio input voltage. connects to CODEC via receive gain setting resistor R_{IN} (see Figure 18). Resistor R_{IN} needs to be as close to the -IN pin as possible to minimize parasitic capacitance.
23	21	VCC	Positive voltage power supply, +3.3V
24	22	CDC	DC Biasing Filter Capacitor - Connects between this pin and V_{CC} . The CDC capacitor may be either polarized or non polarized with a 6.3V voltage rating.
25	23	RT	Ring trip filter network.
26	24	ILIM	Loop Current Limit programming resistor.
27	25	SH	Switch hook detection threshold programming resistor.
---	26	SCC	Substrate Common Connection - Connect this pin to VBH Supply. This pin is used to connect the substrate of the die and the thermal heatsink plane of the QFN package.
28	27	RING	RING power amplifier output.

Absolute Maximum Ratings $T_A = 25^\circ\text{C}$

Maximum Supply Voltages

V_{CC}	-0.5V to +7V
$V_{CC} - V_{BH}$	110V
Uncommitted Switch Voltage	-110V
Maximum Tip/Ring Negative Voltage Pulse (Note 8)	$V_{BH} - 15V$
Maximum Tip/Ring Positive Voltage Pulse (Note 8)	+8V
ESD (Human Body Model)	1000V

Operating Conditions

Temperature Range

Commercial (C suffix)	0°C to 85°C
Industrial (I suffix)	-40°C to 85°C
Positive Power Supply (V_{CC})	$+3.3V \pm 10\%$
Low Battery Power Supply (V_{BL})	$-16V$ to $-52V, \pm 5\%$
High Battery Power Supply (V_{BH})	
ISL5585AIM, CIM, GCM, GCR	V_{BL} to $100V, \pm 5\%$
ISL5585BIM, DIM	V_{BL} to $-85V, \pm 10\%$
ISL5585ECM, ECR, FCM, FCR	V_{BL} to $-75V, \pm 10\%$
Uncommitted Switch (loop back or relay driver)	$+5V$ to $-100V$

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTES:

- θ_{JA} is measured with the component mounted on a low effective thermal conductivity test board in free air. See Tech Brief TB379 for details.
- θ_{JA} is measured in free air with the component mounted on a high effective thermal conductivity test board with "direct attach" features. θ_{JC} , the "case temp" is measured at the center of the exposed metal pad on the package underside. See Tech Brief TB379.

Thermal Information

Thermal Resistance (Typical)	θ_{JA} ($^\circ\text{C}/W$)	θ_{JC} ($^\circ\text{C}/W$)
PLCC (Note 1)	55	N/A
QFN (Note 2)	28	1
Maximum Junction Temperature Plastic	150°C	
Maximum Storage Temperature Range	-65°C to 150°C	
Maximum Lead Temperature (Soldering 10s)	300°C	
(PLCC - Lead Tips Only)		
For Recommended soldering conditions see Tech Brief TB389.		

Die Characteristics

Substrate Potential	V_{BH}
Process	Bipolar-DI

Electrical Specifications Unless Otherwise Specified, $T_A = -40^\circ\text{C}$ to 85°C for industrial (I) grade and $T_A = 0^\circ\text{C}$ to 85°C for commercial (C) grade, $V_{BL} = -24V$, $V_{BH} = -100V, -85V$ or $-75V$, $V_{CC} = +3.3V$, AGND = BGND = 0V, loop current limit = 25mA. All AC transmission parameters are specified at 600W 2-wire terminating impedance over the frequency band of 300Hz to 3.4kHz. Protection resistors = 0W.

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS
RINGING PARAMETERS					
VRS Input Impedance (Note 3)		450	-	-	k Ω
Differential Ringing Gain (Note 4)	Balanced Ringing, VRS to 2-Wire, $R_{LOAD} = \infty$	78	80	82	V/V
	Unbalanced Ringing, VRS to 2-Wire, $R_{LOAD} = \infty$	38	40	42	V/V
Centering Voltage Accuracy	Tip, Referenced to $V_{BH}/2 + 0.5$ (Note 9)	-	± 2.5	-	V
	Ring, Referenced to $V_{BH}/2 + 0.5$	-	± 2.5	-	V
Open Circuit Ringing Voltage	Balanced Ringing, VRS Input = $0.840V_{RMS}$	-	67	-	V_{RMS}
	Unbalanced Ringing, VRS Input = $0.840V_{RMS}$	-	33.5	-	V_{RMS}
Ring Voltage Total Distortion	$R_L = 1.3\text{ k}\Omega$, $V_{T-R} = V_{BH} - 5$	-	-	4.0	%
4-Wire to 2-Wire Ringing Off Isolation	Active Mode, Referenced to VRS Input	-	90	-	dB
2-Wire to 4-Wire Transmit Isolation	Ringing Mode Referenced to the Differential Ringing Amplitude	-	80	-	dB
AC TRANSMISSION PARAMETERS					
Auxiliary Input Impedance (Note 3)		160	-	-	k Ω
Transmit Output Impedance (Note 3)		-	-	1	Ω
4-Wire Port Overload Level	THD = 1%	-	1.0	-	V_{PK}
2-Wire Port Overload Level	THD = 1%	3.1	3.5	-	V_{PK}

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PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS
2-Wire Return Loss	300Hz	-	24	-	dB
	1kHz	-	40	-	dB
	3.4kHz	-	21	-	dB
2-Wire Longitudinal Balance (Notes 5, 6) 300Hz to 1kHz	Forward Active, Grade A and B	58	62	-	dB
	Forward Active, Grade C, D and E	53	59	-	dB
2-Wire Longitudinal Balance (Notes 5, 6) 1kHz to 3.4kHz	Forward Active, Grade A and B	54	58	-	dB
	Forward Active, Grade C, D and E	53	58	-	dB
4-Wire Longitudinal Balance (Notes 5, 6) 300Hz to 1kHz	Forward Active, Grade A and B	58	67	-	dB
	Forward Active, Grade C, D and E	53	64	-	dB
4-Wire Longitudinal Balance (Notes 5, 6) 1kHz to 3.4kHz	Forward Active, Grade A and B	54	66	-	dB
	Forward Active, Grade C, D and E	53	63	-	dB
2-Wire to 4-Wire Level Linearity 4-Wire to 2-Wire Level Linearity Referenced to -10dBm	+3 to -40dBm, 1kHz	-	± 0.025	-	dB
	-40 to -50dBm, 1kHz	-	± 0.050	-	dB
	-50 to -55dBm, 1kHz	-	± 0.100	-	dB
Longitudinal Current Capability Per Wire (Note 3)	OHT, Active	20	-	-	mARMS
4-Wire to 2-Wire Insertion Loss		-0.20	0.00	+0.20	dB
2-Wire to 4-Wire Insertion Loss		-6.22	-6.02	-5.82	dB
4-Wire to 4-Wire Insertion Loss		-6.22	-6.02	-5.82	dB
Forward Active Idle Channel Noise (Note 6)	2-Wire C-Message, $T=25^{\circ}\text{C}$	-	10	13	dBrnC
	4-Wire C-Message, $T=25^{\circ}\text{C}$	-	4	7	dBrnC
Reverse Active Idle Channel Noise (Note 6)	2-Wire C-Message, $T=25^{\circ}\text{C}$	-	10	13	dBrnC
	4-Wire C-Message, $T=25^{\circ}\text{C}$	-	4	7	dBrnC
DC PARAMETERS					
Off Hook Loop Current Limit	Programming Accuracy(1% programming resistor)	-8.5	-	+8.5	%
	Programming Range	15	-	45	mA
Off Hook Transient Current Limit	Programming Accuracy (1% programming resistor)	-20	-	+20	%
	Programming Range	40	-	100	mA
Loop Current During Low Power Standby	Forward Polarity Only	18	-	26	mA
Open Circuit Voltage (Tip - Ring)	$V_{BL} = -16\text{V}$	-	8.0	-	V_{DC}
	$V_{BL} = -24\text{V}$	14	15.5	17	V_{DC}
	$V_{BH} > -60\text{V}$	43	49	-	V_{DC}
Low Power Standby, Open Circuit Voltage (Tip - Ring)	$V_{BL} = -48\text{V}$	-	44.5	-	V_{DC}
	$V_{BH} > -60\text{V}$	43	51.5	-	V_{DC}
Absolute Open Circuit Voltage	V_{RG} in LPS and FA; V_{TG} in RA; $V_{BH} > -60\text{V}$	-	-53	-56	V_{DC}
TEST ACCESS FUNCTIONS					
Switch On Voltage	$I_{OL} = 45\text{mA}$	-	0.20	0.60	V
Loopback Max Battery (V_{BL} or V_{BH})		-	-	52	V

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PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS
LOOP DETECTORS AND SUPERVISORY FUNCTIONS					
Switch Hook Programming Range		5	-	15	mA
Switch Hook Programming Accuracy	(1% programming resistor)	-10	-	+10	%
Dial Pulse Distortion		-	1.0	-	%
Ring Trip Comparator Threshold		1.12	1.25	1.37	V
Ring Trip Programming Current Accuracy	(1% programming resistor)	-10	-	+10	%
Ground Key Threshold		-	12	-	mA
E0 Transition, DET Output Delay		-	20	-	μs
Thermal Alarm Output	IC Junction Temperature	-	175	-	$^{\circ}\text{C}$
LOGIC INPUTS (F0, F1, F2, E0, SWC, BSEL)					
Input Low Voltage		-	-	0.8	V
Input High Voltage		2.0	-	-	V
Input Low Current	$V_{IL}=0.4\text{V}$	-20	-10	-	μA
Input High Current	$V_{IH}=2.4\text{V}$	-	-	1	μA
LOGIC OUTPUTS ($\overline{\text{DET}}$, $\overline{\text{ALM}}$)					
Output Low Voltage	$I_{OL}=1\text{mA}$	-	.15	0.4	V
Output High Voltage	$I_{OH}=100\mu\text{A}$	2.4	2.8	-	V
SUPPLY CURRENTS					
Low Power Standby, BSEL=1	I_{CC}	-	3.9	6.0	mA
	I_{BH}	-	0.66	0.90	mA
Forward or Reverse Active, BSEL=0	I_{CC}	-	4.9	6.5	mA
	I_{BL}	-	1.2	2.5	mA
Forward Active, BSEL=1	I_{CC}	-	7.0	9.5	mA
	I_{BL}	-	0.9	2.0	mA
	I_{BH}	-	2.2	3.0	mA
Ringing, BSEL=1 (Balanced Ringing, 100)	I_{CC}	-	6.4	9.0	mA
	I_{BL}	-	1.0	1.3	mA
	I_{BH}	-	2.0	3.0	mA
Ringing, BSEL=1 (Unbalanced Ringing, 010)	I_{CC}	-	9.3	9.0	mA
	I_{BL}	-	1.0	1.3	mA
	I_{BH}	-	2.4	3.0	mA
Forward Loopback, BSEL=0	I_{CC}	-	10.3	13.5	mA
	I_{BL}	-	23.5	32	mA
Tip Open, BSEL=1	I_{CC}	-	3.8	5.5	mA
	I_{BL}	-	0.4	1.0	mA
	I_{BH}	-	0.6	1.0	mA

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PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Power Denial, BSEL=0 or 1	I_{CC}	-	4.0	6.0	mA
	I_{BL}	-	0.4	1.0	
	I_{BH}	-	0.4	0.6	mA
ON HOOK POWER DISSIPATION (Note 7)					
Forward or Reverse	$V_{BL} = -24\text{V}$	-	55	-	mW
Low Power Standby	$V_{BH} = -100\text{V}$	-	85	-	mW
	$V_{BH} = -85\text{V}$	-	75	-	mW
	$V_{BH} = -75\text{V}$	-	65	-	mW
Ringing	$V_{BH} = -100\text{V}$	-	250	-	mW
	$V_{BH} = -85\text{V}$	-	230	-	mW
	$V_{BH} = -75\text{V}$	-	225	-	mW
OFF HOOK POWER DISSIPATION (Note 7)					
Forward or Reverse	$V_B = -24\text{V}$	-	305	-	mW
POWER SUPPLY REJECTION RATIO					
V_{CC} to 2-Wire	$f = 300\text{Hz}$	-	40	-	dB
	$f = 1\text{kHz}$	-	35	-	dB
	$f = 3.4\text{kHz}$	-	28	-	dB
V_{CC} to 4-Wire	$f = 300\text{Hz}$	-	45	-	dB
	$f = 1\text{kHz}$	-	43	-	dB
	$f = 3.4\text{kHz}$	-	33	-	dB
V_{BL} to 2-Wire	$300\text{Hz} \leq f \leq 3.4\text{kHz}$	-	30	-	dB
V_{BL} to 4-Wire	$300\text{Hz} \leq f \leq 3.4\text{kHz}$	-	35	-	dB
V_{BH} to 2-Wire	$300\text{Hz} \leq f \leq 3.4\text{kHz}$	-	33	-	dB
V_{BH} to 4-Wire	$300\text{Hz} \leq f \leq 1\text{kHz}$	-	40	-	dB
	$1\text{kHz} < f \leq 3.4\text{kHz}$	-	45	-	dB

NOTES:

- These parameters are controlled via design or process parameters and are not directly tested. These parameters are characterized upon initial design release and upon design changes which would affect these characteristics.
- Differential Ringing Gain is measured with $V_{RS} = 0.795V_{RMS}$ for -100V devices, $V_{RS} = 0.663V_{RMS}$ for -85V devices and $V_{RS} = 0.575V_{RMS}$ for -75V devices.
- Longitudinal Balance is tested per IEEE455-1985, with 368Ω per Tip and Ring terminal.
- These parameters are tested 100% at room temperature. These parameters are guaranteed not tested across temperature via statistical characterization and design.
- The power dissipation is based on actual device measurements and will be less than worst case calculations based on data sheet supply current limits.
- Characterized with $2 \times 10\mu\text{s}$, and $10 \times 1000\mu\text{s}$ first level lightning surge waveforms (GR-1089-CORE)
- For Unbalanced Ringing the Tip terminal is offset to 0V and the Ring terminal is centered at $V_{bh}/2 + 0.5\text{V}$.

Design Equations

Switch Hook Detect

The switch hook detect threshold is set by a single external resistor, R_{SH} . Equation 1 is used to calculate the value of R_{SH} .

$$R_{SH} = 600/I_{SH} \quad (\text{EQ. 1})$$

The term I_{SH} is the desired DC loop current threshold. The loop current threshold programming range is from 5mA to 15mA ($40k\Omega < R_{SH} < 120k\Omega$).

Ground Key Detect

The ground key detector senses a DC current imbalance between the Tip and Ring terminals when the ring terminal is connected to ground. The ground key detect threshold is not externally programmable and is internally fixed to 12mA regardless of the switch hook threshold.

Ring Trip Detect

The ring trip detect threshold is set by a single external resistor, R_{RT} . I_{RT} should be set between the peak ringing current and the peak off hook current while still ringing.

$$R_{RT} = 1800/I_{RT} \quad (\text{EQ. 2})$$

In addition, the ring trip current must be set below the transient current limit, including tolerances. The capacitor C_{RT} , in parallel with R_{RT} , will set the ring trip response time.

Loop Current Limit

The loop current limit of the device is programmed by the external resistor R_{IL} . The value of R_{IL} can be calculated using Equation 3.

$$R_{IL} = \frac{1760}{I_{LIM}} \quad (\text{EQ. 3})$$

The term I_{LIM} is the desired loop current limit. The loop current limit programming range is from 15mA to 45mA ($39k\Omega < R_{IL} < 117k\Omega$).

Transient Current Limit

The drive current capability of the output tip and ring amplifiers is programmed by an external resistor R_{TL} . This output current limit is separate from the DC loop current limit function. The current limit circuit works in both the source and sink direction, with an internally fixed offset to prevent the current limit functions from turning on simultaneously. The current limit function is provided by sensing line current and reducing the voltage drive to the load when the externally set threshold is exceeded, hence forcing a constant source or sink current.

Transient Source Current Programming

The source current is externally programmed as shown in Equation 4.

$$R_{TL} = \frac{1650}{I_{SRC}} \quad (\text{EQ. 4})$$

For example a source current limit setting of 95mA is programmed with a $18.7k\Omega$ (R_{TL}) resistor connected from the TL pin of the device to ground. This setting determines the maximum amount of current which flows from Tip to Ring during an off hook event until the DC loop current limit responds. In addition this setting also determines the amount of current which will flow from Tip or Ring when external battery faults occur.

Transient Sink Current Programming

The sink current limit is internally offset 20% higher than the externally programmed source current limit setting.

$$I_{SNK} = 1.20 \times I_{SRC} \quad (\text{EQ. 5})$$

If the source current limit is set to 95mA, the sink current limit will be 114mA. This setting will determine the maximum current that flows into Tip or Ring when external ground faults occur.

Understanding Transient Current Limit

Each tip and ring amplifier is designed to limit source current and sink current. Figure 1 shows the functionality of the circuit for the case of limiting the source current. A similar diagram applies to the sink current limit with current polarity changed accordingly.

During normal operation, the error current (I_{ERR}) is zero and the output voltage is determined by the signal current (I_{SIG}) multiplied by the 200K feedback resistor. With the current polarity as shown for I_{SIG} , the output voltage moves positively with respect to half battery. Assuming the amplifier output is driving a load at a more negative potential, the amplifier output will source current.

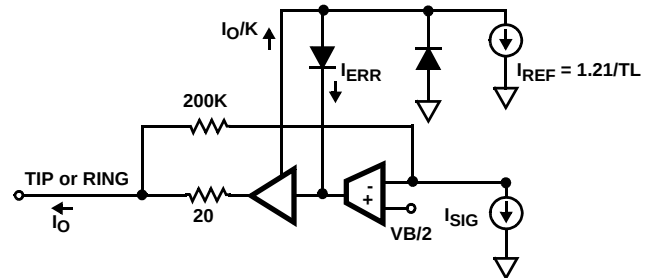


FIGURE 1. CURRENT LIMIT FUNCTIONAL DIAGRAM

During excessive output source current flow, the scaled output current (I_O/K) exceeds the reference current (I_{REF}) forcing an error current (I_{ERR}). With the polarity as shown the error current subtracts from the signal current, which reduces the amplifier output voltage. By reducing the output voltage the source current to the load is decreased and the output current is limited.

Setting the Proper Transient Current Limit

Since this feature programs the maximum output current of the device, the setting must be high enough to allow for

detection of ring trip or programmed off hook loop current, whichever is greater.

To allow for proper ring trip operation, the transient current limit setting should be set at least 25% higher than the peak ring trip current setting. Setting the transient current 25% higher should account for programming tolerances of both the ring trip threshold and the transient current limit.

If loop current is larger than ring trip current (low REN applications) then the transient current limit should be set at least 35% higher than the loop current setting. The slightly higher offset accounts for the slope of the loop current limit function.

Attention to detail should be exercised when programming the transient current limit setting. If ring trip detect does not occur while ringing, then re-examine the transient current limit and ring trip threshold settings.

DC Loop Feed

The feedback mechanism for monitoring the DC portion of the loop current is the loop detector. A low pass filter is used in the feedback to block voice band signals from interfering with the loop current limit function. The pole of the low pass filter is set by the external capacitor C_{DC} . The value of the external capacitor should be $4.7\mu F$, 6.3V rated polarized or non-polarized capacitor.

Most applications will operate the device from low battery while off hook. The DC feed characteristic of the device will drive Tip and Ring towards half battery to regulate the DC loop current. For light loads or Long Loops, Tip will be near -4V and Ring will be near $V_{VBL} + 5V$. Figure 2 shows the DC feed characteristic in terms of tip to ring voltage and loop current.

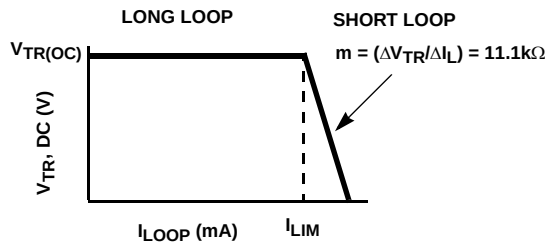


FIGURE 2. DC FEED CHARACTERISTIC

The point on the y-axis labeled $V_{TR(OC)}$ is the open circuit Tip to Ring voltage and is defined by the feed battery voltage in Equation 6.

$$V_{TR(OC)} = |V_{BL}| - 9 \quad (EQ. 6)$$

Figure 3 illustrates the actual loop current for a given set of loop conditions. The loop conditions are determined by the low battery voltage and the DC loop impedance. The DC loop impedance is the sum of the protection resistance, copper resistance (ohms/foot) and the telephone off hook DC resistance.

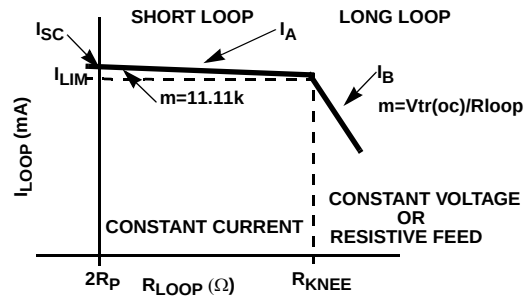


FIGURE 3. I_{LOOP} vs. R_{LOOP} LOAD CHARACTERISTIC

The slope of the feed characteristic and the battery voltage define the maximum loop current on the shortest possible loop as the short circuit current I_{SC} .

$$I_{SC} = I_{LIM} + \frac{V_{TR(OC)} - 2R_P I_{LIM}}{11.11k} \quad (EQ. 7)$$

The term I_{LIM} is the programmed current limit, $1760/R_{IL}$. The line segment I_A represents the constant current region of the loop current limit function.

$$I_A = I_{LIM} + \frac{V_{TR(OC)} - R_{LOOP} I_{LIM}}{11.11k} \quad (EQ. 8)$$

Process variations in the ISL5585 effect the I_{LIM} and $11.11k\Omega$ slope in Equation 8. All units are tested with: a 300Ω load across tip and ring, $V_{BAT} = -24V$ and I_{LIM} set to 25mA. Equation 8 can be used to predict the ideal current at this setting (25.76mA). All units are tested to be within $\pm 8.5\%$ of this ideal value (23.57mA to 27.95mA).

The maximum loop impedance for a programmed loop current is defined as R_{KNEE} .

$$R_{KNEE} = \frac{V_{TR(OC)}}{I_{LIM}} \quad (EQ. 9)$$

When R_{KNEE} is exceeded, the device will transition from constant current feed to constant voltage or resistive feed.

The line segment I_B represents the resistive feed portion of the load characteristic

$$I_B = \frac{V_{TR(OC)}}{R_{LOOP}} \quad (EQ. 10)$$

Impedance Matching

The impedance of the device is programmed with the external component R_S . R_S is the gain setting resistor for the Transmit Amplifier that provides impedance matching. If complex impedance matching is required, then a complex network can be substituted for R_S .

The feedback mechanism for monitoring the AC portion of the loop current consists of two amplifiers, the Sense Amplifier (SA) and the Transmit Amplifier (TA). The AC feedback signal is used for impedance synthesis. A detailed model of the AC feed back loop is shown in Figure 4.

The gain of the Transmit Amplifier, set by R_S , determines the programmed impedance of the device. The capacitor C_{FB} blocks the DC component of the loop current. The ground symbols in the model represent AC grounds, not actual DC potentials.

The Sense Amplifier is configured as a 4 input differential amplifier with a gain of 3/4. The voltage at the output of the sense amplifier (V_{SA}) is calculated using superposition. V_{SA1} is the voltage resulting from V_1 , V_{SA2} is the voltage resulting from V_2 and so on (reference Figure 4).

$$V_{SA1} = -\frac{3}{4}(V_1) \quad (\text{EQ. 11})$$

$$V_{SA2} = \frac{3}{4}(V_2) \quad (\text{EQ. 12})$$

$$V_{SA3} = -\frac{3}{4}(V_3) \quad (\text{EQ. 13})$$

$$V_{SA4} = \frac{3}{4}(V_4) \quad (\text{EQ. 14})$$

$$V_{SA} = [(V_2 - V_1) + (V_4 - V_3)] \frac{3}{4} = [\Delta V + \Delta V] \frac{3}{4} \quad (\text{EQ. 15})$$

Where ΔV is equal to $I_M R_{SENSE}$ ($R_{SENSE} = 20\Omega$)

$$V_{SA} = 2(\Delta I_M \times 20) \frac{3}{4} = \Delta I_M 30 \quad (\text{EQ. 16})$$

The voltage at V_{TX} is equal to:

$$V_{TX} = -V_{IN} \left(\frac{R_S}{R_{IN}} \right) - V_{SA} \left(\frac{R_S}{8k} \right) = -V_{IN} \left(\frac{R_S}{R_{IN}} \right) - (\Delta I_M 30) \left(\frac{R_S}{8k} \right) \quad (\text{EQ. 17})$$

V_{TR} is defined in Figure 4, note polarity assigned to V_{TR} :

$$V_{TR} = 2(V_{TX}) = 2 \left(V_{IN} \left(\frac{R_S}{R_{IN}} \right) + (\Delta I_M 30) \left(\frac{R_S}{8k} \right) \right) \quad (\text{EQ. 18})$$

Setting V_{IN} equal to zero in EQ 18, defining $Z_O = -V_{TR}/\Delta I_M$ and substituting it into EQ18 will enable the user to determine the required feedback to match the line impedance at V_{2W} as shown in Equation 19.

$$Z_O = \frac{1}{133.33} R_S \quad (\text{EQ. 19})$$

2-Wire Impedance Matching

Z_O is the source impedance of the device and is defined as.

$$Z_O = Z_L - 2R_P \quad (\text{EQ. 20})$$

Z_L is the line impedance and R_P is the external protection resistor. R_S is defined as:

$$R_S = 133.33(Z_L - 2R_P) \quad (\text{EQ. 21})$$

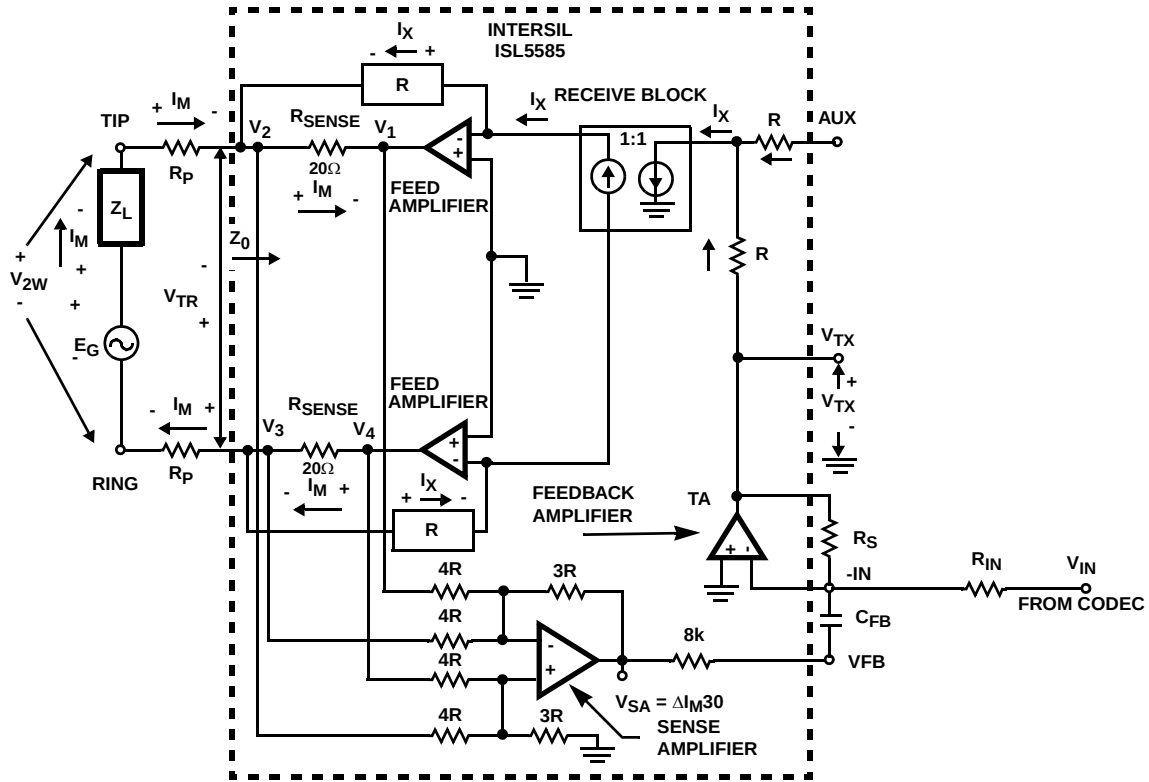


FIGURE 4. AC SIGNAL TRANSMISSION MODEL

Complex Impedance Synthesis

Substituting the impedance programming resistor, R_S , with a complex programming network provides complex impedance synthesis.

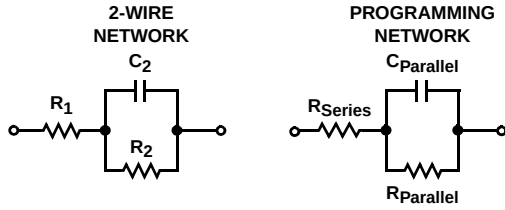


FIGURE 5. COMPLEX PROGRAMMING NETWORK

The reference designators in the programming network match the evaluation board. The component R_S has a different design equation than the R_S used for resistive impedance synthesis. The design equations for each component are provided below.

$$R_{Series} = 133.3 \times (R_1 - 2(R_P)) \quad (\text{EQ. 22})$$

$$R_{Parallel} = 133.3 \times R_2 \quad (\text{EQ. 23})$$

$$C_{Parallel} = C_2 / 133.3 \quad (\text{EQ. 24})$$

Node Equation at ISL5585 AUX input, Figure 4

$$I_X = \frac{AUX}{R} + \frac{V_{TX}}{R} \quad (\text{EQ. 25})$$

Substituting EQ 17 for VTX with $AUX = 0$ and $\Delta I_M = -V_{2W}/Z_L$ gives us EQ 26. Note: AUX input is not used.

Substitute EQ 17 into EQ 21

$$I_X = \frac{V_{TX}}{R} = -\frac{V_{IN}}{R} \left(\frac{R_S}{R_{IN}} \right) - \left(\frac{V_{2W}^{30}}{Z_L} \right) \left(\frac{R_S}{R_{8k}} \right) \quad (\text{EQ. 26})$$

Loop Equation at ISL5585 feed amplifiers and load.

$$I_X R - V_{TR} + I_X R = 0 \quad (\text{EQ. 27})$$

Substitute EQ 26 into EQ 27

$$V_{TR} = -2V_{IN} \left(\frac{R_S}{R_{IN}} \right) + \left(\frac{2V_{2W}^{30}}{Z_L} \right) \left(\frac{R_S}{8k} \right) \quad (\text{EQ. 28})$$

Substitute Equation 19 for $R_S/8k$ in Equation 28.

$$V_{TR} = -2V_{IN} \left(\frac{R_S}{R_{IN}} \right) + \left(\frac{2V_{2W}^{30}}{Z_L} \right) \left(\frac{133.33Z_O}{8k} \right) \quad (\text{EQ. 29})$$

Simplifying

$$V_{TR} = -2V_{IN} \left(\frac{R_S}{R_{IN}} \right) + \left(\frac{V_{2W}}{Z_L} \right) (Z_O) \quad (\text{EQ. 30})$$

Loop Equation at Tip/Ring interface

$$V_{2W} - I_M 2R_P + V_{TR} = 0 \quad (\text{EQ. 31})$$

Substitute Equation 30 into Equation 31 and combine terms

$$V_{2W} \left[\frac{Z_L + Z_O + 2R_P}{Z_L} \right] = 2V_{IN} \frac{R_S}{R_{IN}} \quad (\text{EQ. 32})$$

where:

V_{IN} = The input voltage at the -IN pinthrough resistor R_{IN} .

AUX = Auxiliary input of SLIC. Not used for AC gains.

V_{SA} = An internal node voltage that is a function of the loop current and the output of the Sense Amplifier.

I_X = Internal current in the SLIC that is the difference between the input receive current and the feedback current.

I_M = The AC metallic current.

R_P = A protection resistor (typical 49.9Ω).

R_S = An external resistor/network for matching the line impedance.

V_{TR} = The tip to ring voltage at the output pins of the SLIC.

V_{2W} = The tip to ring voltage including the voltage across the protection resistors.

Z_L = The line impedance.

Z_O = The source impedance of the device.

4-Wire to 2-Wire Gain

4-wire to 2-wire gain across the ISL5585 is equal to the V_{2W} divided by the input voltage V_{IN} , reference Figure 4. The receive gain is calculated using Equation 32.

Equation 33 expresses the receive gain (V_{IN} to V_{2W}) in terms of network impedances. From Equation 21, the value of R_S was set to match the line impedance (Z_L) to the ISL5585 plus the protection resistors ($Z_O + 2R_P$). This results in a 4-wire to 2-wire gain equal to R_S/R_{IN} , as shown in EQ. 33.

$$G_{4-2} = \frac{V_{2W}}{V_{IN}} = 2 \left(\frac{R_S}{R_{IN}} \right) \frac{Z_L}{Z_L + Z_O + 2R_P} = 2 \frac{Z_L}{Z_L + Z_L} = \frac{R_S}{R_{IN}} \quad (\text{EQ. 33})$$

2-Wire to 4-Wire Gain

The 2-wire to 4-wire gain is equal to V_{TX}/E_G with $V_{IN} = 0$, reference Figure 4.

Loop Equation

$$-E_G + Z_L I_M + 2R_P I_M - V_{TR} = 0 \quad (\text{EQ. 34})$$

From Equation 30 with $V_{IN} = 0$

$$V_{TR} = \frac{Z_O V_{2W}}{Z_L} \quad (\text{EQ. 35})$$

Substituting Equation 35 into Equation 34 and simplify.

$$E_G = -V_{2W} \left[\frac{Z_L + 2R_P + Z_O}{Z_L} \right] \quad (\text{EQ. 36})$$

Substituting Equation 19 into Equation 17 ($V_{IN}=0$) and defining $\Delta I_M = -V_{2W}/Z_L$ results in Equation 37 for V_{TX} .

$$V_{TX} = \frac{V_{2W}}{2} \left[\frac{Z_L - 2R_P}{Z_L} \right] \quad (\text{EQ. 37})$$

Combining Equations 36 and 37 results in Equation 38.

$$G_{2-4} = \frac{V_{TX}}{E_G} = -\frac{Z_L - 2R_P}{2(Z_L + 2R_P + Z_O)} = -\frac{Z_O}{2(Z_L + 2R_P + Z_O)} \quad (\text{EQ. 38})$$

A more useful form of the equation is rewritten in terms of V_{TX}/V_{2W} . A voltage divider equation is written to convert from E_G to V_{2W} as shown in Equation 39.

$$V_{2W} = \left(\frac{Z_O + 2R_P}{Z_L + Z_O + 2R_P} \right) E_G \quad (\text{EQ. 39})$$

Substituting $Z_L = Z_O + 2R_P$ and rearranging Equation 39 in terms of E_G results in Equation 40.

$$E_G = 2V_{2W} \quad (\text{EQ. 40})$$

Substituting Equation 40 into Equation 38 results in an equation for 2-wire to 4-wire gain that's a function of the synthesized input impedance of the SLIC and the protection resistors.

$$G_{2-4} = \frac{V_{TX}}{V_{2W}} = -\left(\frac{Z_O}{(Z_L + 2R_P + Z_O)} \right) = 0.416 \quad (\text{EQ. 41})$$

If Z_L is set to 600Ω, Z_O is programmed with R_S to be 498.76Ω (66.5kΩ/133.33), and R_P is equal to 49.9Ω. This results in a 2-wire to 4-wire gain of 0.416 or -7.6dB.

When the protection resistors are set to zero, the transmit gain is -6dB.

Transhybrid Gain

The transhybrid gain is defined as the 4-wire to 4-wire gain (G_{44}).

$$G_{44} = G_{42} \times G_{24} = -\left(\frac{R_S}{R_{IN}} \right) \left(\frac{Z_O}{Z_L + 2R_P + Z_O} \right) \quad (\text{EQ. 42})$$

Understanding Phase Across the ISL5585

4-Wire to 2-Wire Phase

The phase of a signal through the ISL5585 is dependent upon whether the source is driving the signal 4-wire to 2-wire or 2-wire to 4-wire.

Figure 6 illustrates the phase of the input signal across the ISL5585 when the signal is applied at the -IN pin of the ISL5585 through the R_{IN} resistor. The Transmit Amplifier (TA) inverts the signal 180 degrees at the VTX pin. The feedback around the tip amplifier inverts the signal again on the tip lead. The input signal will cause AC loop current to flow through the 20 Ω sense resistors in the direction from V1 to V2 and V3 to V4. This results in an inverted signal (referenced from tip) on the VSA and thus the VFB pin. This out of phase signal is the signal used by the feedback path to match the line impedance of the 2-wire side.

2-Wire to 4-Wire Phase

Figure 7 illustrates the phase of the input signal across the ISL5585 when the signal is applied across tip and ring. When you're driving the 2-wire side with a source the ISL5585 looks like a predetermined impedance (programmed with resistor R_S). The current flows through the 20Ω sense resistors in the direction V2 to V1 and V4 to V3. This results in a non-inverted signal (referenced from tip) on the VSA and thus the VFB pin. This signal is then inverted by the TA amplifier and the signal appearing on the VTX output is out of phase with the signal on tip.

Summary of the Phase Through the ISL5585

4-Wire to 2-Wire (V_{IN} to V_{2W}) is 180° out of phase

2-Wire to 4-Wire (V_{2W} to V_{TX}) is 180° out of phase

4-Wire to 4-Wire (V_{IN} to V_{TX}) is 180° out of phase

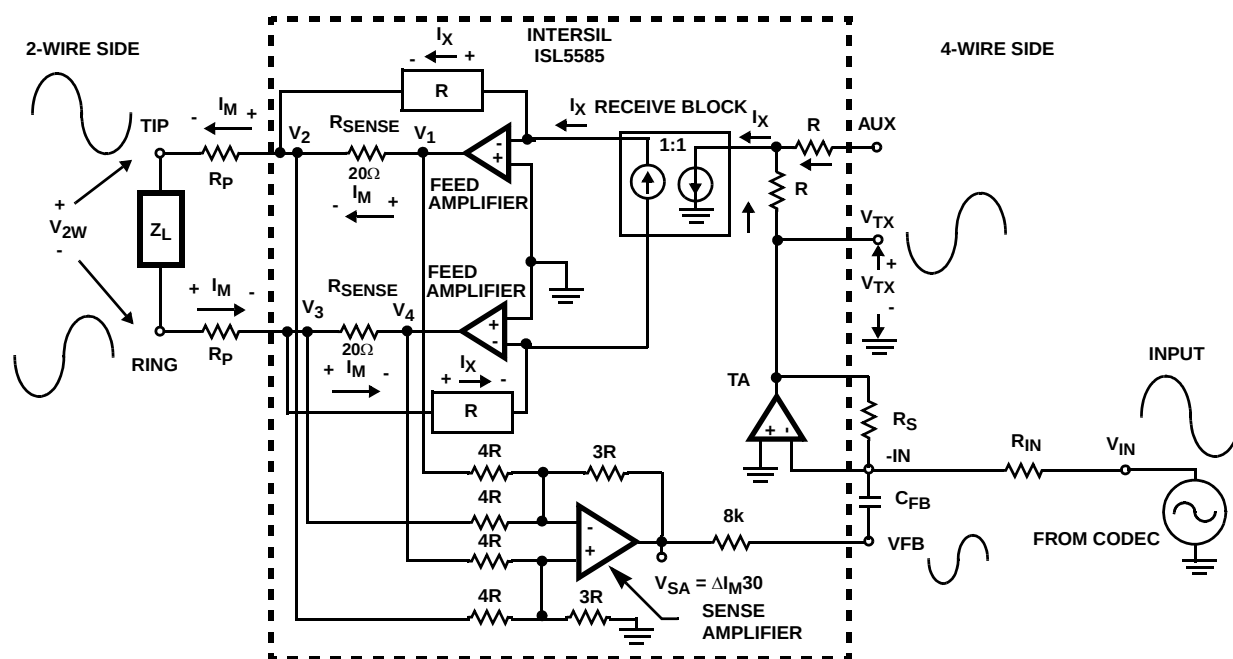


FIGURE 6. 4-WIRE TO 2-WIRE SIGNAL PHASE ACROSS THE ISL5585

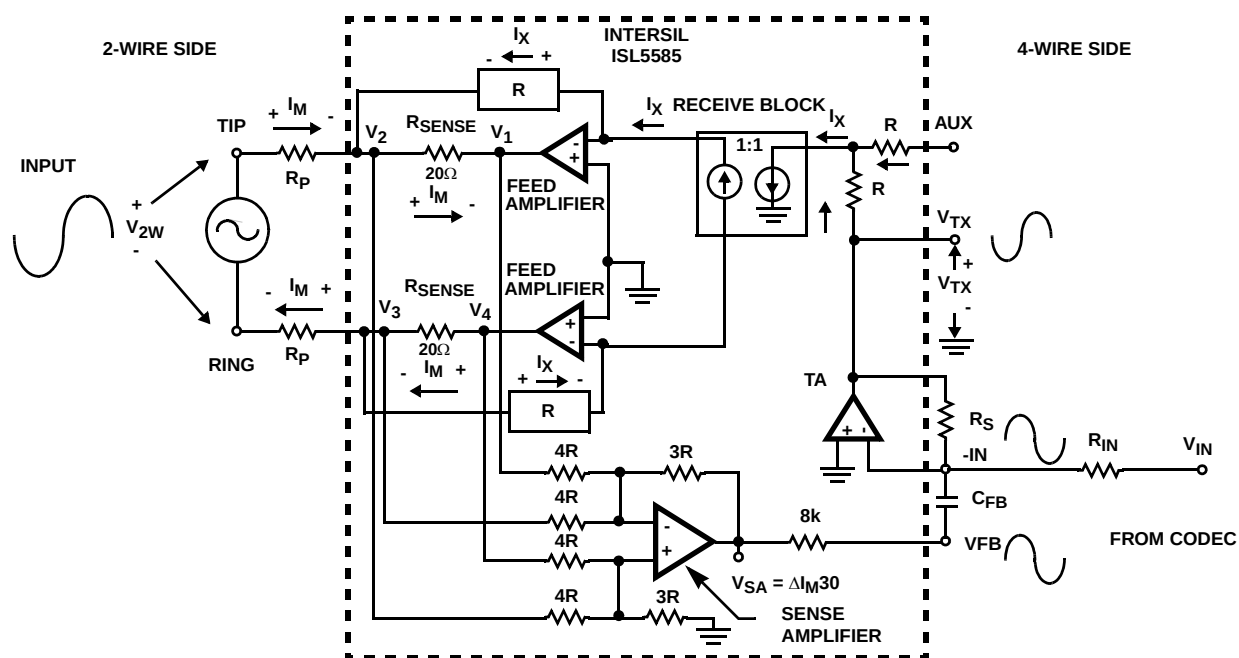


FIGURE 7. 2-WIRE TO 4-WIRE SIGNAL PHASE ACROSS THE ISL5585

Low Power Standby

Overview

The low power standby mode (LPS, 000) should be used during idle line conditions. The device is designed to operate from the high battery during this mode. Most of the internal circuitry is powered down, resulting in low power dissipation. If the 2-wire (tip/ring) DC voltage requirements are not critical during idle line conditions, the device may be operated from the low battery. Operation from the low battery will decrease the standby power dissipation.

TABLE 1. DEVICE INTERFACES DURING LPS

INTERFACE	ON	OFF	NOTES
Receive		x	AC transmission, impedance matching and ringing are disabled during this mode.
Ringing		x	
Transmit		x	
2-Wire	x		Amplifiers disabled.
Loop Detect	x		Switch hook or ground key.

2-Wire Interface

During LPS, the 2-wire interface is maintained with internal switches and voltage references. The Tip and Ring amplifiers are turned off to conserve power. The device will provide MTU compliance, loop current and loop supervision. Figure 8 represents the internal circuitry providing the 2-wire interface during low power standby.

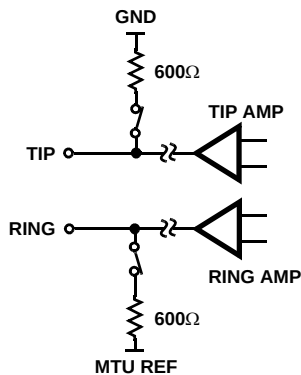


FIGURE 8. LPS 2-WIRE INTERFACE CIRCUIT DIAGRAM

MTU Compliance

Maintenance Termination Unit or MTU compliance places DC voltage requirements on the 2-wire terminals during idle line conditions. The minimum idle voltage is 42.75V. The high side of the MTU range is 56V. The voltage is expressed as the difference between Tip and Ring.

The Tip voltage is held near ground through a 600Ω resistor and switch. The Ring voltage is limited to a maximum of -56V (by MTU REF) when operating from either the high or low battery. A switch and 600Ω resistor connect the MTU reference to the Ring terminal. When the high battery

voltage exceeds the MTU reference of -56V, the Ring terminal will be clamped by the internal reference (typically -54V). The same Ring relationships apply when operating from the low battery voltage. For high battery voltages (V_{BH}) less than or equal to the internal MTU reference threshold:

$$V_{RING} = V_{BH} + 5 \quad (\text{EQ. 43})$$

Loop Current

During LPS, the device will provide current to a load. The current path is through resistors and switches, and is a function of the off hook loop resistance (R_{LOOP}). This includes the off hook phone resistance and copper loop resistance. The current available during LPS is determined by Equation 44.

$$I_{LOOP} = (-1 - (-54)) / (600 + 600 + R_{LOOP}) \quad (\text{EQ. 44})$$

Internal current limiting of the standby switches will limit the maximum current to approximately 20mA.

Another loop current related parameter is longitudinal current capability. The longitudinal current capability is reduced. The reduction in longitudinal current capability is a result of turning off the Tip and Ring amplifiers.

On Hook Power Dissipation

The on hook power dissipation of the device during LPS is determined by the operating voltages and quiescent currents and is calculated using Equation 45.

$$P_{LPS} = V_{BH} \times I_{BHQ} + V_{BL} \times I_{BLQ} + V_{CC} \times I_{CCQ} \quad (\text{EQ. 45})$$

The quiescent current terms are specified in the electrical tables for each operating mode. Load power dissipation is not a factor since this is an on hook mode. Some applications may specify a standby current. The standby current may be a charging current required for modern telephone electronics.

Standby Current Power Dissipation

Any standby line current, I_{SLC} , introduces an additional power dissipation term P_{SLC} . Equation 46 illustrates the power contribution is zero when the standby line current is zero.

$$P_{SLC} = I_{SLC} \times (|V_{BH}| - 54 + 1 + I_{SLC} \times 1200) \quad (\text{EQ. 46})$$

If the battery voltage is less than -54V (the MTU clamp is off), the standby line current power contribution reduces to Equation 47.

$$P_{SLC} = I_{SLC} \times (|V_{BH}| + 1 + I_{SLC} \times 1200) \quad (\text{EQ. 47})$$

If the loop length is greater than R_{KNEE} , the device is operating in the constant voltage, resistive feed region. The power dissipated in this region is calculated using Equation 53.

$$P_{FA(IB)} = P_{FA(Q)} + (V_{BL} \times I_B) - (R_{LOOP} \times I_B^2) \quad (EQ. 53)$$

Since the current relationships are different for constant current versus constant voltage, the region of device operation is critical to valid power dissipation calculations.

Reverse Active

Overview

The reverse active mode (RA, 011) provides the same functionality as the forward active mode. On hook transmission, DC loop feed and voice transmission are supported. Loop supervision is provided by either the switch hook detector ($E0 = 1$) or the ground key detector ($E0 = 0$). The device may be operated from either high or low battery.

During reverse active the Tip and Ring DC voltage characteristics exchange roles. That is, Ring is typically 4V below ground and Tip is typically 4V more positive than battery. Otherwise, all feed and voice transmission characteristics are identical to forward active.

Silent Polarity Reversal

Changing from forward active to reverse active or vice versa is referred to as polarity reversal. Many applications require slew rate control of the polarity reversal event. Requirements range from minimizing cross talk to protocol signalling.

The device uses an external low voltage capacitor, C_{POL} , to set the reversal time. Once programmed, the reversal time will remain nearly constant over various load conditions. In addition, the reversal timing capacitor is isolated from the AC loop, therefore loop stability is not impacted.

The internal circuitry used to set the polarity reversal time is shown in Figure 11.

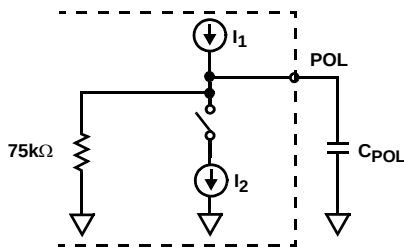


FIGURE 11. REVERSAL TIMING CONTROL

During forward active, the current from source I_1 charges the external timing capacitor C_{POL} and the switch is open. The internal resistor provides a clamping function for voltages on the POL node. During reverse active, the switch closes and I_2 (roughly twice I_1) pulls current from I_1 and the timing capacitor. The current at the POL node provides the drive to

a differential pair which controls the reversal time of the Tip and Ring DC voltages.

$$C_{POL} = \frac{\Delta time}{75000} \quad (EQ. 54)$$

Where $\Delta time$ is the required reversal time. Polarized capacitors may be used for C_{POL} . The low voltage at the POL pin and minimal voltage excursion $\pm 0.75V$, are well suited to polarized capacitors.

Power Dissipation

The power dissipation equations for forward active operation also apply to the reverse active mode.

Ringling

Overview

The ringing mode (RNG, 100) provides linear amplification to support a variety of ringing waveforms. A programmable ring trip function provides loop supervision and auto disconnect upon ring trip. The device is designed to operate from the high battery during this mode.

Architecture

The device provides linear amplification to the signal applied to the ringing input, V_{RS} . The differential ringing gain of the device is 80V/V. The circuit model for the ringing path is shown in Figure 12.

The voltage gain from the VRS input to the Tip output is 40V/V. The resistor ratio provides a gain of 8 and the current mirror provides a gain of 5. The voltage gain from the VRS input to the Ring output is -40V/V.

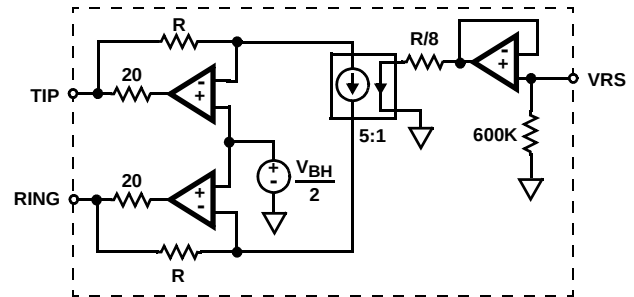


FIGURE 12. LINEAR RINGING MODEL

The equations for the Tip and Ring outputs during ringing are provided below.

$$V_T = \frac{V_{BH}}{2} + (40 \times VRS) \quad (EQ. 55)$$

$$V_R = \frac{V_{BH}}{2} - (40 \times VRS) \quad (EQ. 56)$$

When the input signal at VRS is zero, the Tip and Ring amplifier outputs are centered at half battery. The device provides auto centering for easy implementation of sinusoidal ringing waveforms. Both AC and DC control of the Tip and Ring outputs is available during ringing. This feature allows for DC offsets as part of the ringing waveform.

Ringing Input

The ringing input, V_{RS} , is a high impedance input. The high impedance allows the use of low value capacitors for AC coupling the ring signal. The V_{RS} input is enabled only during the ringing mode, therefore a free running oscillator may be connected to VRS at all times.

When operating from a battery of -100V, each amplifier, Tip and Ring, will swing a maximum of 95V_{P-P}. Hence, the maximum signal swing at VRS to achieve full scale ringing is approximately 2.4V_{P-P}. The low signal levels are compatible with the output voltage range of the CODEC. The digital nature of the CODEC ideally suits it for the function of programmable ringing generator.

Logic Control

Ringing patterns consist of silent intervals. The ringing to silent pattern is called the ringing cadence. During the silent portion of ringing, the device can be programmed to any other operating mode. The most likely candidates are low power standby or forward active. Depending on system requirements, the low or high battery may be selected.

Loop supervision is provided with the ring trip detector. The ring trip detector senses the change in loop current when the phone is taken off hook. The loop detector full wave rectifies the ringing current, which is then filtered with external components R_{RT} and C_{RT} . The resistor R_{RT} sets the trip threshold and the capacitor C_{RT} sets the trip response time. Most applications will require a trip response time less than 150ms.

Three very distinct actions occur when the device detects a ring trip. First, the $\overline{DET}$ output is latched low. The latching mechanism eliminates the need for software filtering of the detector output. The latch is cleared when the operating mode is changed externally. Second, the VRS input is disabled, removing the ring signal from the line. Third, the device is internally forced to the forward active mode.

Power Dissipation

The power dissipation during ringing is dictated by the load driving requirements and the ringing waveform. The key to valid power calculations is the correct definition of average and RMS currents. The average current defines the high battery supply current. The RMS current defines the load current.

The cadence provides a time averaging reduction in the peak power. The total power dissipation consists of ringing power, P_r , and the silent interval power, P_s .

$$P_{RNG} = P_r \times \frac{t_r}{t_r + t_s} + P_s \times \frac{t_s}{t_r + t_s} \quad (\text{EQ. 57})$$

The terms t_r and t_s represent the cadence. The ringing interval is t_r and the silent interval is t_s . The typical cadence ratio $t_r:t_s$ is 1:2.

The quiescent power of the device in the ringing mode is defined in Equation 58.

$$P_{r(Q)} = V_{BH} \times I_{BHQ} + V_{BL} \times I_{BLQ} + V_{CC} \times I_{CCQ} \quad (\text{EQ. 58})$$

The total power during the ringing interval is the sum of the quiescent power and loading power:

$$P_r = P_{r(Q)} + V_{BH} \times I_{AVG} - \frac{V_{RMS}^2}{Z_{REN} + R_{LOOP}} \quad (\text{EQ. 59})$$

For sinusoidal waveforms, the average current, I_{AVG} , is defined in Equation 60.

$$I_{AVG} = \left(\frac{2}{\pi}\right) \frac{V_{RMS} \times \sqrt{2}}{Z_{REN} + R_{LOOP}} \quad (\text{EQ. 60})$$

The silent interval power dissipation will be determined by the quiescent power of the selected operating mode.

Unbalanced Ringing

The ISL5585GCM offers Unbalanced Ringing mode (010). This feature accommodates some Analog PBX Trunk Lines that require the Tip terminal to be held near ground for the duration of the ringing bursts. The Tip terminal is offset to 0V's with an internal current source that is applied to the inverting input of the Tip amplifier. This reduces the differential ringing gain to 40V/V. The Ring terminal will center at $V_{bh}/2$ and swing from $-V_{bh}$ to ground. As in Balanced Ringing, off hook detection is accomplished by sensing the peak current and comparing it to a preset threshold. This allows the same sensing, comparing and threshold circuitry to be used in both Ringing modes. This mode of operation does not require any additional external components.

Forward Loop Back

Overview

The Forward Loop Back mode (FLB, 101) provides test capability for the device. An internal signal path is enabled allowing for both DC and AC verification. The internal 600Ω terminating resistor has a tolerance of ±20%. The device is intended to operate from only the low battery during this mode.

Architecture

When the forward loop back mode is initiated internal switches connect a 600Ω load across the outputs of the Tip and Ring amplifiers.

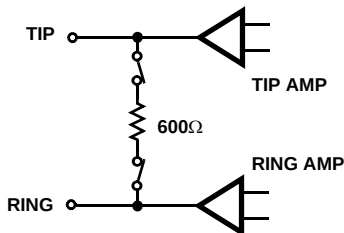


FIGURE 13. FORWARD LOOP BACK INTERNAL TERMINATION

DC Verification

When the internal signal path is provided, DC current will flow from Tip to Ring. The DC current will force $\overline{DET}$ low, indicating the presence of loop current. In addition, the $\overline{ALM}$ output will also go low. This does not indicate a thermal alarm condition. Rather, proper logic operation is verified in the event of a thermal shutdown. In addition to verifying device functionality, toggling the logic outputs verifies the interface to the system controller.

AC Verification

The entire AC loop of the device is active during the forward loop back mode. Therefore a 4-wire to 4-wire level test capability is provided. Depending on the transhybrid balance implementation, test coverage is provided by a one or two step process.

System architectures which cannot disable the transhybrid function would require a two step process. The first step would be to send a test tone to the device while on hook and not in forward loop back mode. The return signal would be the test level times the gain R_F/R_A of the transhybrid amplifier. Since the device would not be terminated, cancellation would not occur. The second step would be to program the device to FLB and resend the test tone. The return signal would be much lower in amplitude than the first step, indicating the device was active and the internal termination attenuated the return signal. System architectures which disable the transhybrid function would achieve test coverage with a signal step. Once the transhybrid function is disabled, program the device for FLB and send the test tone. The return signal level is determined by the 4-wire to 4-wire gain of the device.

Tip Open

Overview

The tip open mode (110) is intended for compatibility for PBX type interfaces. Used during idle line conditions, the device does not provide transmission. Loop supervision is provided by either the switch hook detector ($E0 = 1$) or the ground key detector ($E0 = 0$). The ground key detector will be used in most applications. The device may be operated from either high or low battery.

Functionality

During tip open operation, the Tip switch is disabled and the Ring switch is enabled. The minimum Tip impedance is $30k\Omega$. The only active path through the device will be the Ring switch.

In keeping with the MTU characteristics of the device, Ring will not exceed -56V when operating from the high battery. Though MTU does not apply to tip open, safety requirements are satisfied.

Power Denial

Overview

The power denial mode (111) will shutdown the entire device except for the logic interface. Loop supervision is not provided. This mode may be used as a sleep mode or to shut down in the presence of a persistent thermal alarm. Switching between high and low battery will have no effect during power denial.

Functionality

During power denial, both the Tip and Ring amplifiers are disabled, representing high impedances. The voltages at both outputs are near ground.

Thermal Shutdown

In the event the safe die temperature is exceeded, the $\overline{\text{ALM}}$ output will go low and $\overline{\text{DET}}$ will go high and the part will automatically shut down. When the device cools, $\overline{\text{ALM}}$ will go high and $\overline{\text{DET}}$ will reflect the loop status. If the thermal fault persists, $\overline{\text{ALM}}$ will go low again and the part will shut down. Programming power denial will permanently shutdown the device and stop the self cooling cycling.

Battery Switching

Overview

The integrated battery switch selects between the high battery and low battery. The battery switch is controlled with the logic input BSEL. When BSEL is a logic high, the high battery is selected and when a logic low, the low battery is selected. All operating modes of the device will operate from high or low battery except forward loop back, which requires low battery for thermal reasons.

Functionality

The logic control is independent of the operating mode decode. Independent logic control provides the most flexibility and will support all application configurations.

When changing device operating states, battery switching should occur simultaneously with or prior to changing the operating mode. In most cases, this will minimize overall power dissipation and prevent glitches on the $\overline{\text{DET}}$ output.

The only external component required to support the battery switch is a diode in series with the VBH supply lead. In the event that high battery is removed, the diode allows the device to transition to low battery operation.

Low Battery Operation

All off hook operating conditions should use the low battery. The prime benefit will be reduced power dissipation. The typical low battery for the device is -24V. However this may be increased to support longer loop lengths or high loop current requirements. Standby conditions may also operate from the low battery if MTU compliance is not required, further reducing standby power dissipation.

High Battery Operation

Other than during ringing, the high battery should be used for standby conditions which must provide MTU compliance. During standby operation the power consumption is typically 85mW with -100V battery. If ringing requirements do not require full 100V operation, then a lower battery will result in lower standby power.

High Voltage Decoupling

The 100V rating of the device will require a capacitor of higher voltage rating for decoupling. Suggested decoupling values for all device pins are 0.1 μF . Standard surface mount ceramic capacitors are rated at 100V. For applications driven at low cost and small size, the decoupling scheme shown below could be implemented.

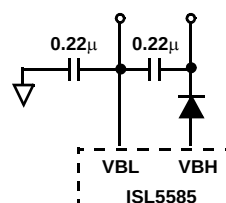


FIGURE 14. ALTERNATE DECOUPLING SCHEME

It is important to place the external diode between the VBH pin and the decoupling capacitor. Attaching the decoupling capacitor directly to the VBH pin will degrade the reliability of the device. Refer to Figure 14 for the proper arrangement. This applies to both single and stacked and decoupling arrangements.

If VBL and VBH are tied together to override the battery switch function, then the external diode is not needed and the decoupling may be attached directly to VBH.

Uncommitted Switch

Overview

The uncommitted switch is a three terminal device designed for flexibility. The independent logic control input, $\overline{\text{SWC}}$, allows switch operation regardless of device operating mode. The switch is activated by a logic low. The positive and negative terminals of the device are labeled SW+ and SW- respectively.

Relay Driver

The uncommitted switch may be used as a relay driver by connecting SW+ to the relay coil and SW- to ground. The

switch is designed to have a maximum on voltage of 0.6V with a load current of 45mA.

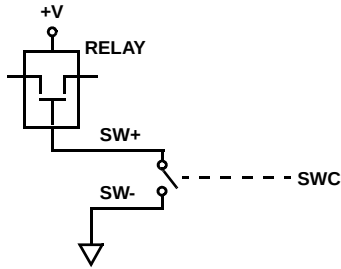


FIGURE 15. EXTERNAL RELAY SWITCHING

Since the device provides the ringing waveform, the relay functions which may be supported include subscriber disconnect, test access or line interface bypass. An external snubber diode is not required when using the uncommitted switch as a relay driver.

Test Load

The switch may be used to connect test loads across Tip and Ring. The test loads can provide external test termination for the device. Proper connection of the uncommitted switch to Tip and Ring is shown below.

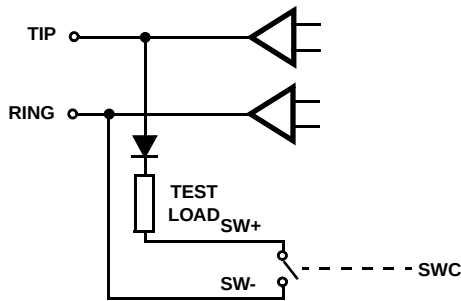


FIGURE 16. TEST LOAD SWITCHING

The diode in series with the test load blocks current from flowing through the uncommitted switch when the polarity of the Tip and Ring terminals are reversed. In addition to the reverse active state, the polarity of Tip and Ring are reversed for half of the ringing cycle. With independent logic control and the blocking diode, the uncommitted switch may be continuously connected to the Tip and Ring terminals.

TABLE 2. ISL5585 3V APPLICATION CIRCUIT COMPONENTS

COMPONENT	VALUE	TOL	RATING
U1 - Ringing SLIC	ISL5585	N/A	N/A
R _{TL}	18.7kΩ	1%	0.1W
R _{RT}	23.7kΩ	1%	0.1W
R _{SH}	49.9kΩ	1%	0.1W
R _{IL}	71.5kΩ	1%	0.1W
R _S	66.5kΩ	1%	0.1W
R _F	30.1kΩ	1%	0.1W
R _A	36.5kΩ	1%	0.1W
R _B	42.2KkΩ	1%	0.1W
R _{IN}	45.3kΩ	1%	0.1W
C _{RS} , C _{TX} , C _{RT} , C _{POL}	0.47μF	20%	10V
C _{DC} , C _{FB}	4.7μF	20%	6.3V
C _{PS1}	0.1μF	20%	>100V
C _{PS2} , C _{PS3}	0.1μF	20%	100V
D ₁	1N400X type with breakdown > 100V.		
R _{P1} , R _{P2} Standard applications will use ≥ 49Ω per side. Protection resistor values are application dependent and will be determined by protection requirements.			

Design Parameters: Ring Trip Threshold = 76mA_{PEAK}, Switch Hook Threshold = 12mA, Loop Current Limit = 24.6mA, Synthesize Device Impedance = $(3 \times 66.5k\Omega) / 400 = 498.8\Omega$, with 49.9Ω protection resistors, impedance across Tip and Ring terminals = 599Ω. Transient current limit = 95mA.

Special Considerations for the QFN Package

The new Quad Flatpack No-lead (QFN) package offers a significant footprint reduction (65%) and improved thermal performance with respect to the 28 lead PLCC. To realize the thermal enhancements and maintain the high voltage (-100V) performance, the exposed pad on the bottom of the QFN package should be soldered to a power/heat sink plane that is electrically connected to the ISL5585 Substrate Common Connection (SCC) pin. The heat is distributed evenly across the board by way of the heat sink plane. This is accomplished by using conductive thermal vias. Reference technical brief TB379 and AN9922 for additional information on thermal characterization and board layout considerations.

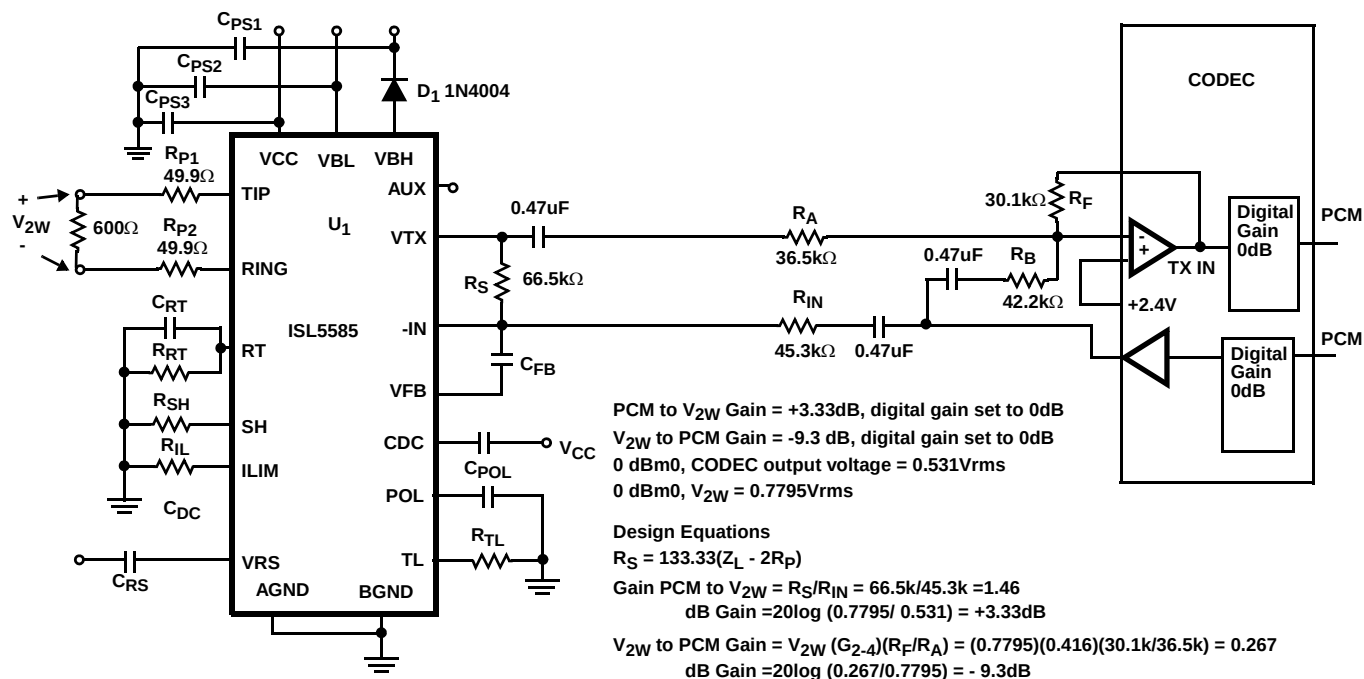
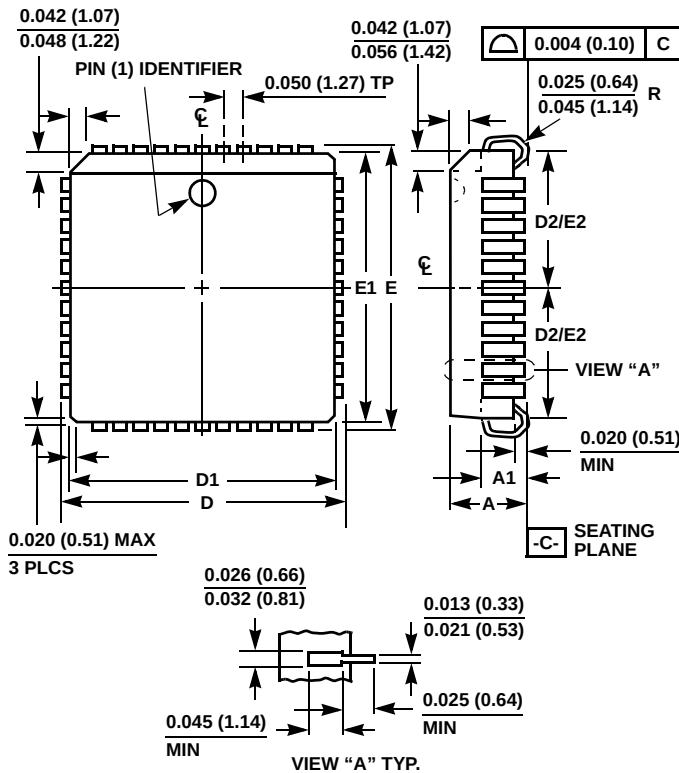


FIGURE 17. ISL5585 3.3V APPLICATION CIRCUIT

Plastic Leaded Chip Carrier Packages (PLCC)



N28.45 (JEDEC MS-018AB ISSUE A) 28 LEAD PLASTIC LEADED CHIP CARRIER PACKAGE

SYMBOL	INCHES		MILLIMETERS		NOTES
	MIN	MAX	MIN	MAX	
A	0.165	0.180	4.20	4.57	-
A1	0.090	0.120	2.29	3.04	-
D	0.485	0.495	12.32	12.57	-
D1	0.450	0.456	11.43	11.58	3
D2	0.191	0.219	4.86	5.56	4, 5
E	0.485	0.495	12.32	12.57	-
E1	0.450	0.456	11.43	11.58	3
E2	0.191	0.219	4.86	5.56	4, 5
N	28		28		6

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NOTES:

- Controlling dimension: INCH. Converted millimeter dimensions are not necessarily exact.
- Dimensions and tolerancing per ANSI Y14.5M-1982.
- Dimensions D1 and E1 do not include mold protrusions. Allowable mold protrusion is 0.010 inch (0.25mm) per side. Dimensions D1 and E1 include mold mismatch and are measured at the extreme material condition at the body parting line.
- To be measured at seating plane -C- contact point.
- Centerline to be determined where center leads exit plastic body.
- "N" is the number of terminal positions.

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